MOSFET - Power, Dual N- & P-Channel, SO8

100 V, 83 m Ω , 4.5 A, -100 V, 131 m Ω , -3.6 A

NTMC083NP10M5L

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- The Part is Not ESD Protected
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- Motor Drive, Home Automation

MAXIMUM RATINGS (T_J = 25°C, Unless otherwise specified)

Parameter			Symbol	Q1	Q2	Unit
Drain-to-Source Breakdown Voltage			V _{(BR)DSS}	100	-100	٧
Gate-to-Source	Voltage		V _{GS}	±20	±20	٧
Continuous Drain Current	Steady State	T _C = 25°C	I _D	4.1	-3.3	Α
R _{θJC} (Note 2)	State	T _C = 100°C		2.5	-2	
Power Dissi-	Steady State	T _C = 25°C	P _D	3.1	3.1	W
pation $R_{\theta JC}$ (Note 2)	State	T _C = 100°C		1.2	1.2	
Continuous Drain Current	Steady T _A = 25°C		I _D	2.9	-2.4	Α
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.8	-1.4	
Power Dissipation R _{0.IA}	Steady State	T _A = 25°C	P_{D}	1.6	1.6	W
(Notes 1, 2)	Olale	T _A = 100°C		0.6	0.6	
Pulsed Drain Current	T _A = 25°C	C, t _p = 10 μs	I _{DM}	20	20	Α
	Operating Junction and Storage Temperature Range			–55 to	+150	°C
Source Current (Body Diode)			Is	3	3	Α
Single Pulse Drain-to-Source Avalanche Energy (I _L = 6 A, 8.2 A, L = 1 mH)			E _{AS}	18	34	mJ
Soldering Purpos	Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			260	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in² pad size, 1 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

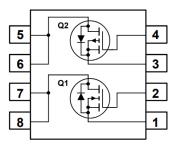


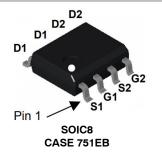
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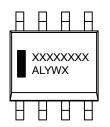
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
100 V	83 mΩ @ 10 V	4.5 A
-100 V	131 mΩ @ 10 V	-3.6 A

Dual-Channel MOSFET





MARKING DIAGRAM



A = Assembly Location

= Wafer Lot

W = Work Week X = Pb-Free

ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	l Parameter		Q2	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State (Note 3)	40	40	°C/W
$R_{ hetaJA}$	R _{0JA} Junction-to-Ambient - Steady State (Note 3)		78	

^{3.} The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) ($T_J = 25$ °C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-		•	-	-	<u>-</u>
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μA	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J	I _D = 250 μA, ref to 25°C		60		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	T _J = 25°C	;		1	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}$ $T_{J} = 125^{\circ}\text{ C}$			100	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±100	nA
ON CHARACTERISTICS			•			
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 28 \mu A$	1.0	1.9	3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} / T _J	I _D = 22 μA, ref to 25°C		8.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 1.5 A		59.4	83	mΩ
		V _{GS} = 4.5 V, I _D = 1.2 A		96.3	118	1
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D} = 4 \text{ A}$		7.1		S
Gate-Resistance	R _G	T _A = 25°C		1.21		Ω
CHARGES & CAPACITANCES				1		
Input Capacitance	C _{ISS}			222		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 50 V		55.4		1
Reverse Transfer Capacitance	C _{RSS}			2.6		
Total Gate Charge	Q _{G(TOT)}			3		nC
Threshold Gate Charge	Q _{G(TH)}			0.6		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 50 \text{ V}, I_D = 1.5 \text{ A}$		0.9		1
Gate-to-Drain Charge	Q_{GD}			1		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DD} = 50 V, I _D = 1.5 A		5		
SWITCHING CHARACTERISTICS				1		
Turn-On Delay Time	t _{d(ON)}			8.4		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} = 50 V, I _D = 1.5 A,		8		
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 6 \Omega$		8.9		1
Fall Time	t _f			6.2		
Turn-On Delay Time	t _{d(ON)}			5.7		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 50 \text{ V}, I_D = 1.5 \text{ A},$		2		
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 6 \Omega$		11.2		1
Fall Time	t _f			4.6		1
OFF CHARACTERISTICS	1		1			1
Forward Diode Voltage	V _{SD}	Voc = 0 V	;	0.8	1.2	V
-		$V_{GS} = 0 \text{ V},$ $I_{S} = 1.5 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$		1.3		1

ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T_J = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			19		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$		13		
Discharge Time	t _b	V_{GS} = 0 V, dI_S/dt = 100 A/ μ s, I_S = 0.8 A		6		
Reverse Recovery Charge	Q _{RR}			11		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Parameter	Symbol	Test Condition	าร	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J	I _D = 250 μA, ref to	25°C		54		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$				1	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}$	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS	•						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = -2$	28 μΑ	-2.0	-3.0	-4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} / T _J	I _D = -28 μA, ref to 25°C			6.61		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 110 V, I _D = -1.5 A			109	131	mΩ
		$V_{GS} = -6 \text{ V}, I_D = -1 \text{ A}$			141	198	1
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D} = -7 \text{ A}$			7.9		S
Gate-Resistance	R_{G}	T _A = 25°C			3.36		Ω
CHARGES & CAPACITANCES	•						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = -50 V			525		pF
Output Capacitance	C _{OSS}				88		
Reverse Transfer Capacitance	C _{RSS}				4		
Total Gate Charge	Q _{G(TOT)}				8.4		nC
Threshold Gate Charge	Q _{G(TH)}				1.8		7
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -10 \text{ V}, V_{DS} = -50 \text{ V}$	/, I _D = -1.5 A		2.7		
Gate-to-Drain Charge	Q_{GD}				1.3		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 6 V, V _{DD} = 50 V,	I _D =-1.5 A		5.2		1
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t _{d(ON)}				10.1		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} = -50 V	In = -1.5 A.		2.7		1
Turn-Off Delay Time	t _{d(OFF)}	$R_{G} = 6 \Omega$			15.9		1
Fall Time	t _f				6.8		
Turn-On Delay Time	t _{d(ON)}				13.3		ns
Rise Time	t _r	$V_{GS} = -6 \text{ V}, V_{DS} = -50 \text{ V}, I_{D} = -41.5 \text{A}, R_{G} = 6 \Omega$			5.7		1
Turn-Off Delay Time	t _{d(OFF)}				12.5		1
Fall Time	t _f				7		1

ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T_J = 25°C unless otherwise noted) (continued)

	(·)	, (0		, (,		
Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		-0.8	-1.2	V
Forward Diode Voltage		$V_{GS} = 0 \text{ V},$ $I_{S} = -1.5 \text{ A}$	T _J = 125°C		-0.7		
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dI_S/dt = 100 A/ μ s, I_S = -0.8 A			31		ns
Charge Time	t _a				23		
Discharge Time	t _b				8		
Reverse Recovery Charge	Q _{RR}				42		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Device	Device Marking	Package	Shipping (Qty / Packing) [†]
NTMC083NP10M5L	83NP10M5	SO8 (Pb–Free/Halogen Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS - N-CHANNEL

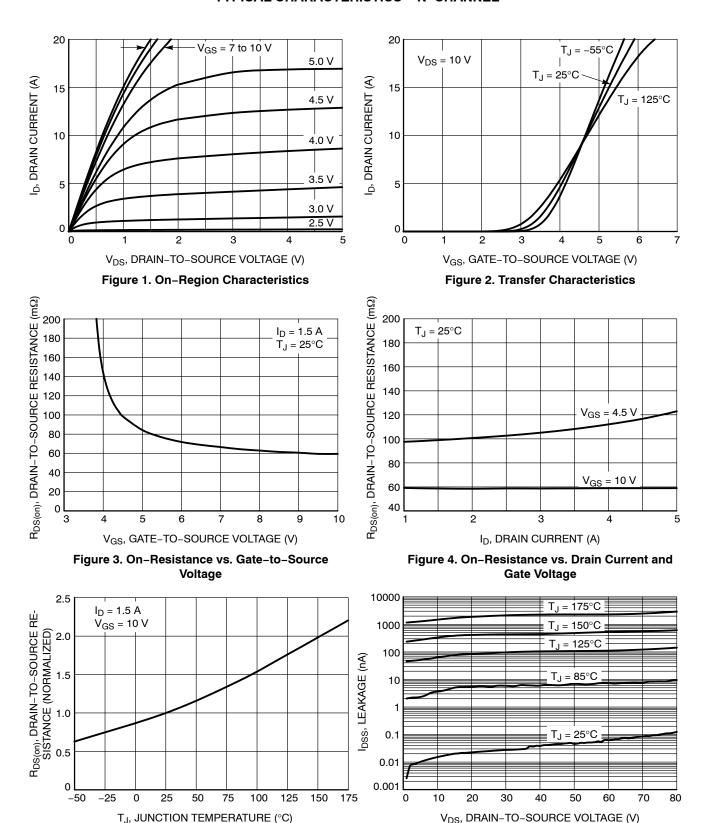
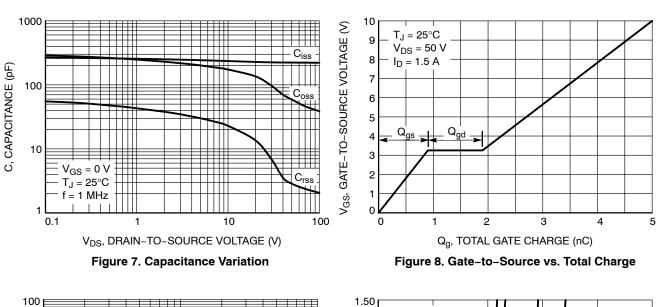


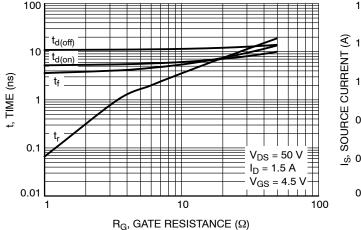
Figure 6. Drain-to-Source Leakage Current vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS - N-CHANNEL







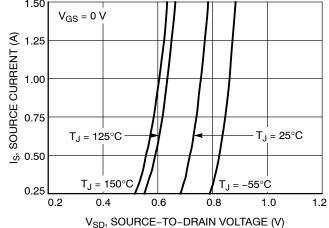


Figure 10. Diode Forward Voltage vs. Current

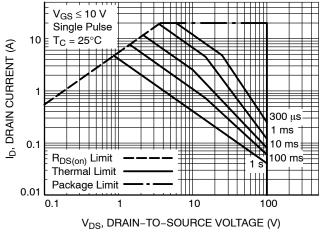


Figure 11. Maximum Rated Forward Biased Safe Operating Area

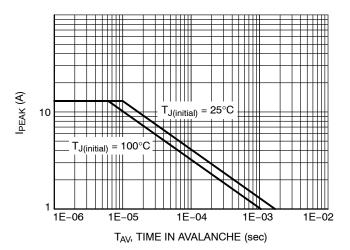


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS - N-CHANNEL

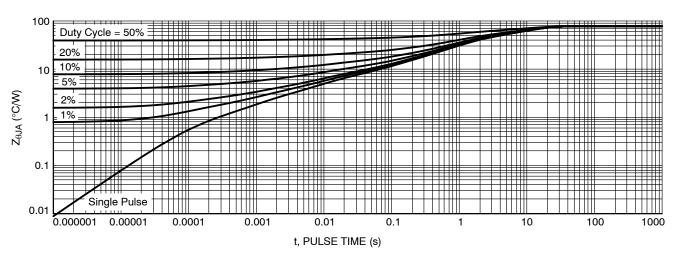


Figure 13. Thermal Response

TYPICAL CHARACTERISTICS - P-CHANNEL

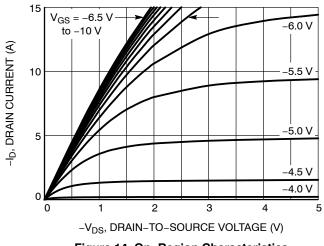


Figure 14. On-Region Characteristics

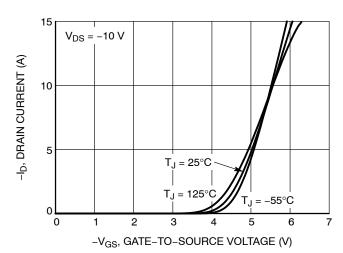


Figure 15. Transfer Characteristics

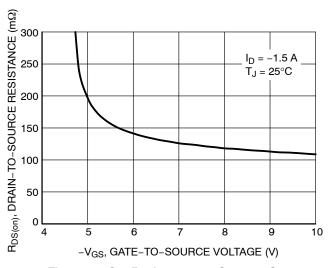


Figure 16. On-Resistance vs. Gate-to-Source Voltage

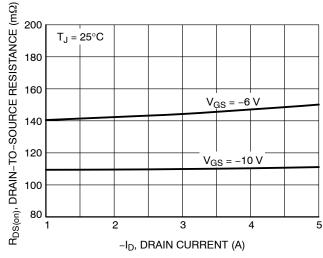


Figure 17. On-Resistance vs. Drain Current and Gate Voltage

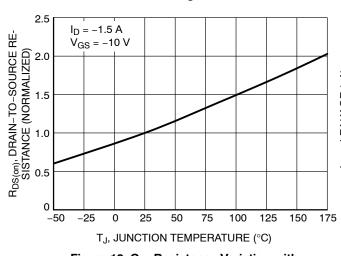


Figure 18. On–Resistance Variation with Temperature

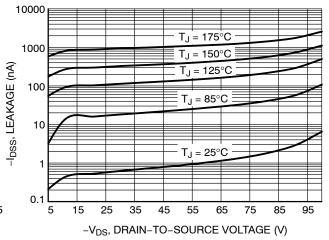


Figure 19. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS - P-CHANNEL

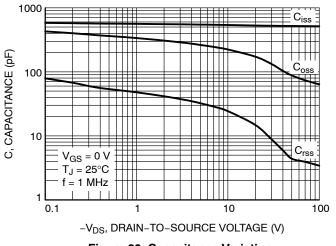


Figure 20. Capacitance Variation

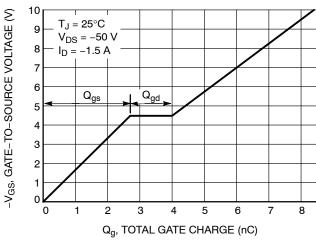


Figure 21. Gate-to-Source vs. Total Charge

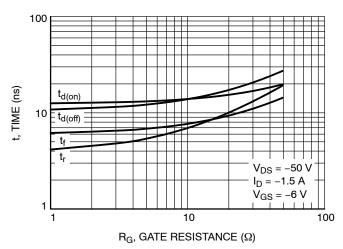


Figure 22. Resistive Switching Time Variation vs. Gate Resistance

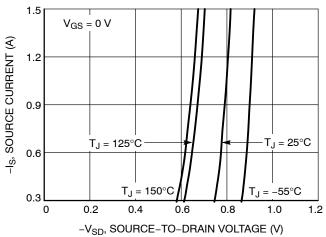


Figure 23. Diode Forward Voltage vs. Current

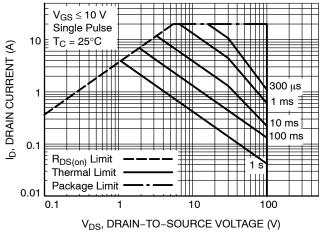


Figure 24. Maximum Rated Forward Biased Safe Operating Area

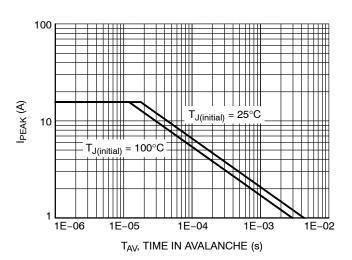


Figure 25. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS - P-CHANNEL

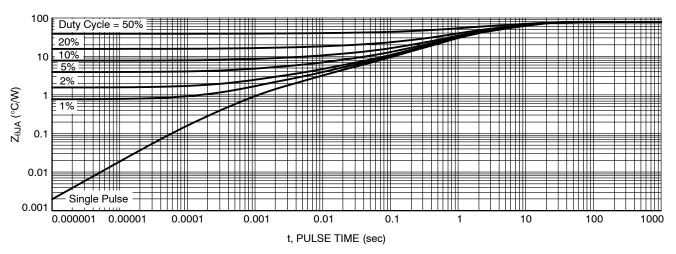
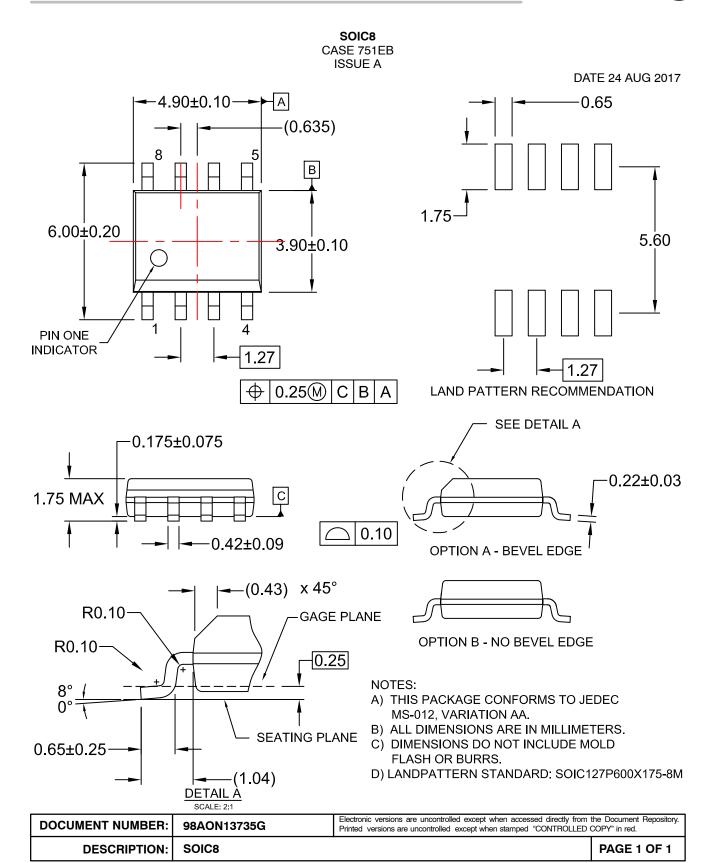


Figure 26. Thermal Response



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